

Product Overview

NSI6602H is a family of high reliability isolated dual-channel gate driver ICs which can be designed to drive power transistor up to 2MHz switching frequency. Each output could source 6A and sink 8A peak current with fast 33ns propagation delay and 6ns maximum delay matching.

The NSI6602H provides 3000V_{rms} isolation in SOP16 package, 2500V_{rms} isolation per UL1577 in 5-mm x 5-mm LGA13 package, and 5700V_{rms} isolation in SOW16 or SOW14 package. System robustness is supported by 150kV/ μ s typical common-mode transient immunity (CMTI).

The driver operates with a maximum supply voltage of 25V, while the input-side accepts from 3V to 18V supply voltage. Under voltage lock-out (UVLO) protection is supported by all the power supply voltage pins.

Key Features

- Isolated dual channel driver
- Input side supply voltage: 3V to 18V
- Driver side supply voltage: up to 25V with UVLO
- 6A peak source and 8A peak sink output
- High CMTI: $\pm 150\text{kV}/\mu\text{s}$ typical
- 33ns typical propagation delay
- 6ns maximum delay matching
- 8ns maximum pulse width distortion
- Programmable deadtime
- Accepts minimum input pulse width 20ns
- Operation temperature: $-40^{\circ}\text{C} \sim 125^{\circ}\text{C}$
- RoHS & REACH Compliant

Safety Regulatory Approvals

- UL recognition:

- SOW16/SOW14: 5700V_{rms} for 1 minute per UL1577
- SOP16: 3000V_{rms} for 1 minute per UL1577
- LGA13 (5x5mm): 2500V_{rms} for 1 minute per UL1577

- DIN EN IEC 60747-17 (VDE 0884-17)
- CSA component notice 5A
- CQC certification per GB4943.

Applications

- Isolated DC-DC and AC-DC power supplies in server, telecom, and industry
- DC-AC solar inverters
- Motor drives and EV charging
- UPS and battery chargers

Device Information

Part Number	Body Size(mm)	Package
NSI6602Hx-DSWR	10.3X7.5X2.65	SOW16
NSI6602Hx-DSWKR	10.3X7.5X2.65	SOW14
NSI6602Hx-DSPNR	9.9X3.9X1.75	SOP16
NSI6602Hx-DLAR	5X5X0.91	LGA13

Functional Block Diagram

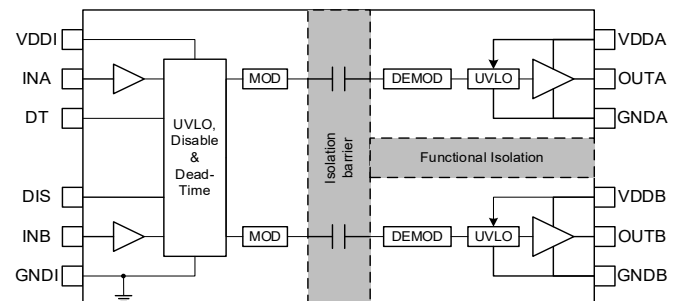


Figure 0.1 NSI6602H Block Diagram

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1. Pin Configuration and Functions

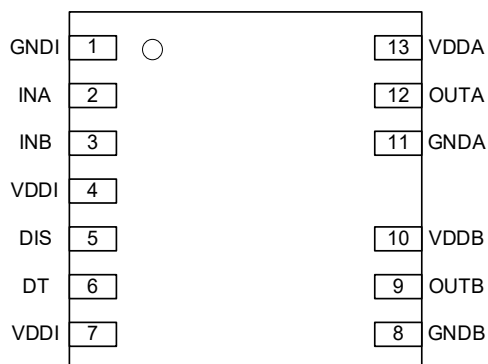


Figure 1.1 NSI6602H LGA13 Package

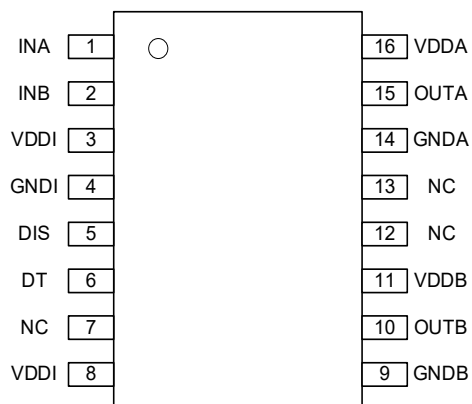


Figure 1.2 NSI6602H SOW16/ SOP16 Package

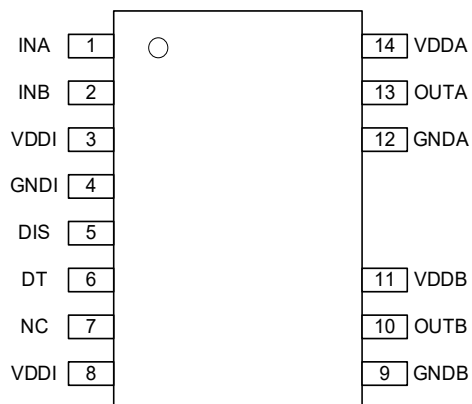


Figure 1.3 NSI6602H SOW14 Package

Table 1.1 NSI6602H Pin Configuration and Description

LGA13	PIN NO.		SYMBOL	FUNCTION
	SOW16/ SOP16	SOW14		
1	4	4	GNDI	Input-side ground reference.
2	1	1	INA	TTL compatible input signal for channel A with internal pull down to GNDI. It is recommended to connect this pin to GNDI if not used.
3	2	2	INB	TTL compatible input signal for channel B with internal pull down to GNDI. It is recommended to connect this pin to GNDI if not used.
4, 7	3, 8	3, 8	VDDI	Input-side supply voltage. It is recommended to place a bypass capacitor from this pin to GNDI as close as possible.
5	5	5	DIS	Disables the isolator inputs and driver outputs if asserted high, enables if asserted low or left open. It is recommended to connect this pin to GNDI if not used.
6	6	6	DT	Programmable deadtime control. - DT pin short to VCCI disables dead time interlock function to allow the outputs overlapping. - DT pin open or floating enables interlock function, deadtime will be typically 8ns. - Place a 1kΩ - 200kΩ resistor (RDT) between DT and GND to adjust deadtime following: $t_{DT} (ns) = 10 \times R_{DT} (k\Omega)$. Connecting with a low ESR 2.2nF capacitor to GND is recommended to limit the noise interference.
8	9	9	GNDB	Ground for output channel B
9	10	10	OUTB	Output gate driver for channel B
10	11	11	Vddb	Supply voltage for channel B
11	14	12	GNDA	Ground for output channel A
12	15	13	OUTA	Output gate driver for channel A
13	16	14	VDDA	Supply voltage for channel A
/	7,12,13	7	NC	Not connected

2. Absolute Maximum Ratings

Parameters	Symbol	Min	Max	Unit
Input Side Supply Voltage	VDDI to GNDI	-0.3	24	V
Output Side Supply Voltage	VDDA to GNDA, Vddb to GNDB	-0.3	30	V
Input Signal Voltage	INA, INB, DIS, DT to GNDI	-0.3	V _{VDDI} +0.3	V

<i>Parameters</i>	<i>Symbol</i>	<i>Min</i>	<i>Max</i>	<i>Unit</i>
	INA, INB, DIS, DT to GNDI, Transient for 50ns	-5	V _{VDDI} +0.3	V
Output Signal Voltage	OUTA to GNDA, OUTB to GNDB	-0.3	V _{VDDA} +0.3 V _{Vddb} +0.3	V
	OUTA to GNDA, OUTB to GNDB, Transient for 200ns	-2	V _{VDDA} +0.3 V _{Vddb} +0.3	V
Channel A to Channel B Voltage	GNDA to GNDB in LGA13 (5 x 5) package		700	V
	GNDA to GNDB in SOP16&SOW16 package		1500	V
	GNDA to GNDB in SOW14 package		1850	V
Junction Temperature	T _J	-40	150	°C
Storage Temperature	T _{stg}	-65	150	°C

3. ESD Ratings

<i>Ratings</i>		<i>Value</i>	<i>Unit</i>
Electrostatic discharge	Human body model (HBM), per AEC-Q100-002-RevD ● All pins	±3.0	kV
	Charged device model (CDM), per AEC-Q100-011-RevB ● All pins	±1500	V

4. Recommended Operating Conditions

<i>Parameters</i>	<i>Symbol</i>	<i>Min</i>	<i>Max</i>	<i>Unit</i>
Input Side Supply Voltage	VDDI to GNDI	3	18	V
Driver Side Supply Voltage	VDDA to GNDA, Vddb to GNDB	V _{VDDA_ON} , V _{Vddb_ON}	25	V
Input Signal Voltage	INA, INB, DIS, DT	0	V _{VDDI}	V
Ambient Temperature	T _a	-40	125	°C

5. Thermal Information

<i>Parameters</i>	<i>Symbol</i>	<i>LGA13</i>	<i>SOW16/ SOW14</i>	<i>SOP16</i>	<i>Unit</i>
Junction-to-ambient thermal resistance ¹⁾	R _{JA}	209.5	97.0	150.5	°C/W
Junction-to-case(top) thermal resistance ²⁾	R _{JC (top)}	48.4	23.3	21.2	°C/W
Junction-to-top characterization parameter ³⁾	Ψ _{JT}	41.8	35.8	52.3	°C/W

<i>Parameters</i>	<i>Symbol</i>	<i>LGA13</i>	<i>SOW16/ SOW14</i>	<i>SOP16</i>	<i>Unit</i>
Junction-to-board characterization parameter ³⁾	Ψ_{JB}	31.9	39.0	55.6	°C/W

- 1) Standard JESD51-3 Low Effective Thermal Conductivity Test Board (1s) in an environment described in JESD51-2a.
- 2) Standard JESD51-3 Low Effective Thermal Conductivity Test Board (1s) by transient dual interface test method described in JESD51-14.
- 3) Obtained by Simulating in an environment described in JESD51-2a.

6. Specifications

6.1. Electrical Characteristics

VDDI=3.3V or 5V, VDDA=VDDDB=15V, Ta=-40°C to 125°C. Unless otherwise noted, Typical values are at Ta=25°C.

Parameter	Symbol	Min	Typ	Max	Unit	Comments
Input Side Supply						
VDDI Quiescent Current	I _{VDDIQ}		1.0	2	mA	INA=0, INB=0
VDDI Operating Current	I _{VDDI}		1.6		mA	Input frequency 500kHz
VDDI UVLO Rising Threshold	V _{VDDI_ON}	2.5	2.7	2.9	V	
VDDI UVLO Falling Threshold	V _{VDDI_OFF}	2.3	2.5	2.7	V	
VDDI UVLO Hysteresis ⁽¹⁾	V _{VDDI_HYS}		0.2		V	
Output Side Supply						
VDDA/B Quiescent Current, per Channel	I _{VDDAQ} , I _{VDDBQ}		1	2	mA	INA=0, INB=0
VDDA/B Operation Current, per Channel	I _{VDDA} , I _{VDDDB}		3		mA	100pF, 500kHz, VDDx=15V
VDDA/B UVLO Rising Threshold	V _{VDDA_ON} , V _{VDDDB_ON}	5.7	6.15	6.5	V	NSI6602HA (6V)
VDDA/B UVLO Falling Threshold	V _{VDDA_OFF} , V _{VDDDB_OFF}	5.4	5.85	6.2	V	
VDDA/B UVLO Hysteresis ⁽¹⁾	V _{VDDA_HYS} , V _{VDDDB_HYS}		0.3		V	
VDDA/B UVLO Rising Threshold	V _{VDDA_ON} , V _{VDDDB_ON}	8.1	8.5	8.9	V	NSI6602HB (8V)
VDDA/B UVLO Falling Threshold	V _{VDDA_OFF} , V _{VDDDB_OFF}	7.6	8.0	8.4	V	
VDDA/B UVLO Hysteresis ⁽¹⁾	V _{VDDA_HYS} , V _{VDDDB_HYS}		0.5		V	
VDDA/B UVLO Rising Threshold	V _{VDDA_ON} , V _{VDDDB_ON}	12.7	13.2	13.7	V	NSI6602HC (12V)
VDDA/B UVLO Falling Threshold	V _{VDDA_OFF} , V _{VDDDB_OFF}	11.7	12.2	12.7	V	
VDDA/B UVLO Hysteresis ⁽¹⁾	V _{VDDA_HYS} , V _{VDDDB_HYS}		1		V	
VDDA/B UVLO Rising Threshold	V _{VDDA_ON} , V _{VDDDB_ON}	3.9	4.2	4.4	V	NSI6602HD (4V)
VDDA/B UVLO Falling Threshold	V _{VDDA_OFF} , V _{VDDDB_OFF}	3.5	3.8	4.1	V	
VDDA/B UVLO Hysteresis ⁽¹⁾	V _{VDDA_HYS} , V _{VDDDB_HYS}		0.4		V	

Parameter	Symbol	Min	Typ	Max	Unit	Comments
Input Side Characteristic						
Input Pin Pull Down Resistance, INA, INB	R_{INA_PD}, R_{INB_PD}		100		k Ω	
Input Pin Pull Down Resistance, DIS (EN)	R_{DIS_PD}		100		k Ω	
Logic High Input Threshold	$V_{INA_H}, V_{INB_H}, V_{DIS_H}$		1.8	2	V	
Logic Low Input Threshold	$V_{INA_L}, V_{INB_L}, V_{DIS_L}$	0.8	1.1		V	
Input Hysteresis ⁽¹⁾	$V_{INA_HYS}, V_{INB_HYS}, V_{DIS_HYS}$		0.7		V	
Output Side Characteristic						
Logic High Output Voltage	$V_{VDDA}-V_{OUTA_H}, V_{Vddb}-V_{OUTB_H}$		0.1		V	$I_{out} = 100mA$
Logic Low Output Voltage	V_{OUTA_L}, V_{OUTB_L}		35		mV	$I_{out} = -100mA$
Output Source Resistance	R_{OUTA_H}, R_{OUTB_H}		1		Ω	$I_{out} = 100mA$
Output Sink Resistance	R_{OUTA_L}, R_{OUTB_L}		0.35		Ω	$I_{out} = -100mA$
Peak Output Source Current ⁽¹⁾	I_{OUTA+}, I_{OUTB+}		6		A	
Peak Output Sink Current ⁽¹⁾	I_{OUTA-}, I_{OUTB-}		8		A	

⁽¹⁾ Not test covered, guaranteed by characterization.

6.2. Switching Characteristics

VDDI=3.3V or 5V, VDDA=Vddb=15V, Ta=-40°C to 125°C. Unless otherwise noted, Typical values are at Ta=25°C.

Parameter	Symbol	Min	Typ	Max	Unit	Comments
Minimum Pulse Width	t_{PWmin}		15	20	ns	
Propagation Delay	t_{PDHL}, t_{PDLH}		33	45	ns	
Pulse Width Distortion $ t_{PDLH}-t_{PDHL} $	t_{PWD}			8	ns	
Channel to Channel Delay Matching	t_{DMLH}, t_{DMHL}			6	ns	
Programmed Deadtime	t_{DT}	160	200	240	ns	$t_{DT}(ns)=10 \cdot R(k\Omega)$; Test for R = 20k Ω
Output Rise Time (10% to 90%)	t_R		15		ns	CL=1.8nF, VDDx=15V
Output Fall Time (90% to 10%)	t_F		15		ns	CL=1.8nF, VDDx=15V
Shutdown Time from Disable True	t_{DIS}		70	100	ns	
Recovery Time from Disable False	t_{EN}		70	100	ns	
VDDI Power-up Time Delay (Time from VDDI = V _{VDDI_ON} to OUTA/B = INA/B)	t_{start_VDDI}		12		μs	INA or INB tied to VDDI

Parameter	Symbol	Min	Typ	Max	Unit	Comments
VDDA/B Power-up Time Delay (Time from VDDA/B = V _{VDD_ON} to OUTA/B = INA/B)	t _{start_VDDA} , t _{start_Vddb}		18		μs	INA or INB tied to VDDI C _{OUTA/B} =1.8nF
Common Mode Transient Immunity ⁽²⁾	CMTI	100	150		kV/μs	verified by design

⁽¹⁾ Not test covered, guaranteed by characterization.

⁽²⁾ Not test covered, guaranteed by design.

6.3. Typical Performance Characteristics

VDDI=3.3V or 5V, VDDA=Vddb=15V, TA = 25°C. Output has no load unless otherwise noted.

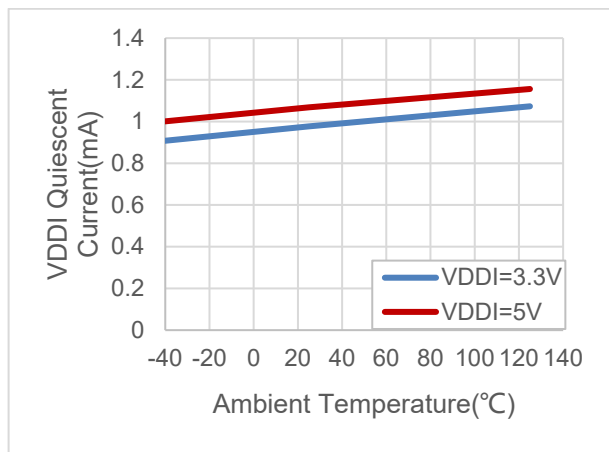


Figure 6.1 VDDI Quiescent Current vs. Temperature

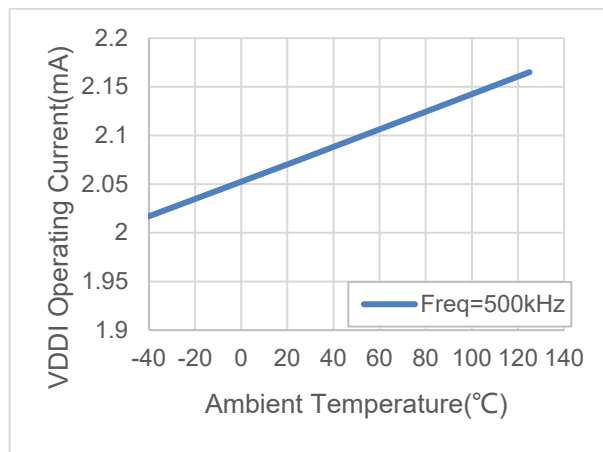


Figure 6.2 VDDI Operating Current vs. Temperature

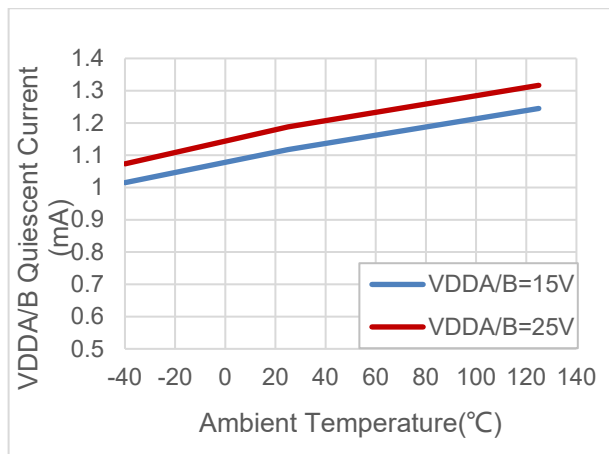


Figure 6.3 VDDA/B Quiescent Current vs. Temperature

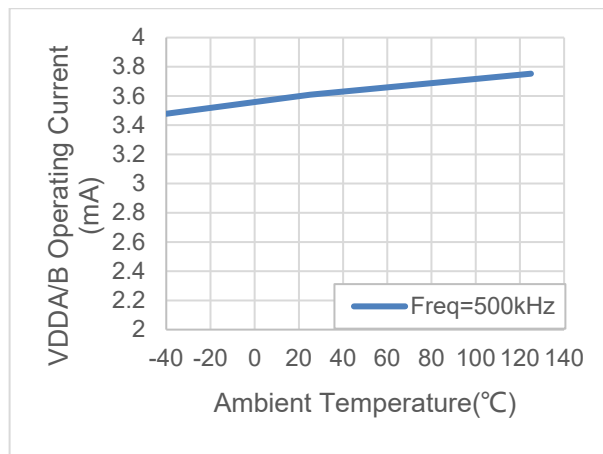


Figure 6.4 VDDA/B Operating Current vs. Temperature

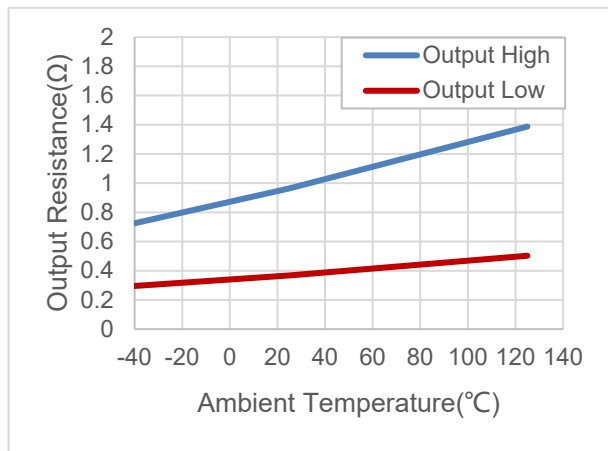


Figure 6.5 Output Resistance vs. Temperature

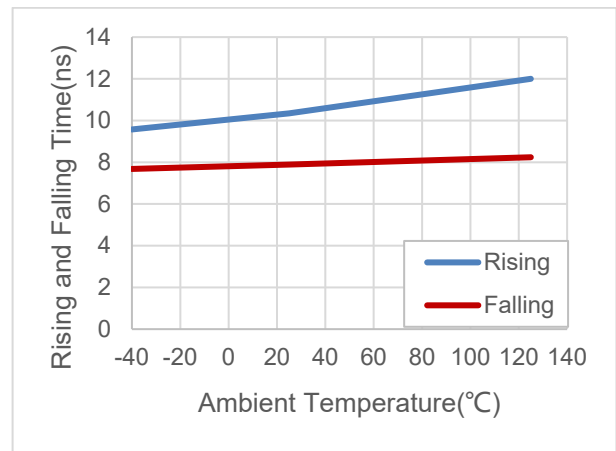


Figure 6.6 Typical Rise Time & Fall Time vs. Temperature

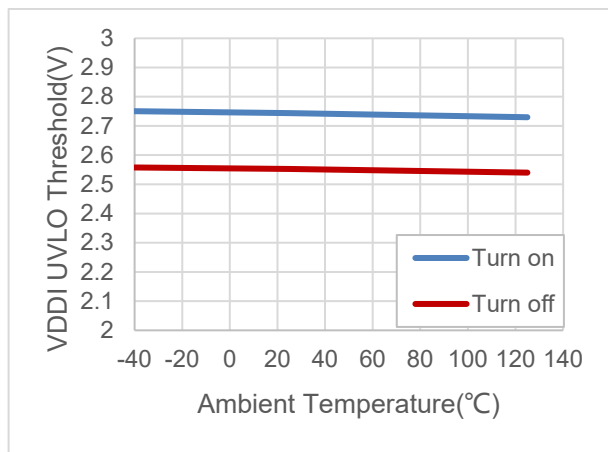


Figure 6.7 VDDI UVLO Threshold vs. Temperature

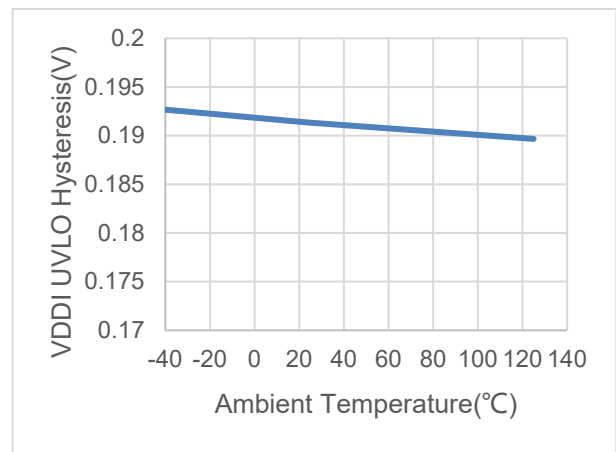


Figure 6.8 VDDI UVLO Hysteresis vs. Temperature

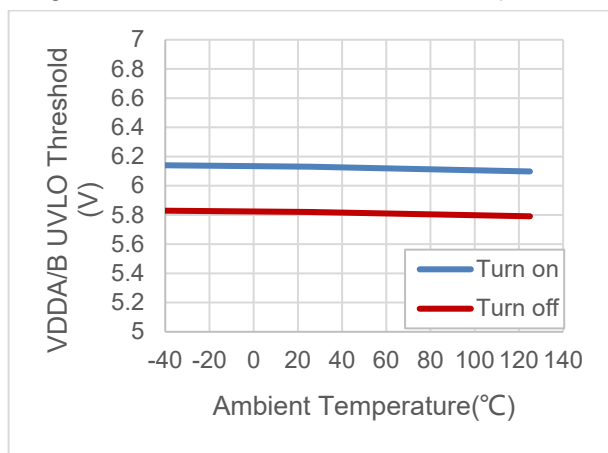


Figure 6.9 6V VDDA/B UVLO Threshold vs. Temperature

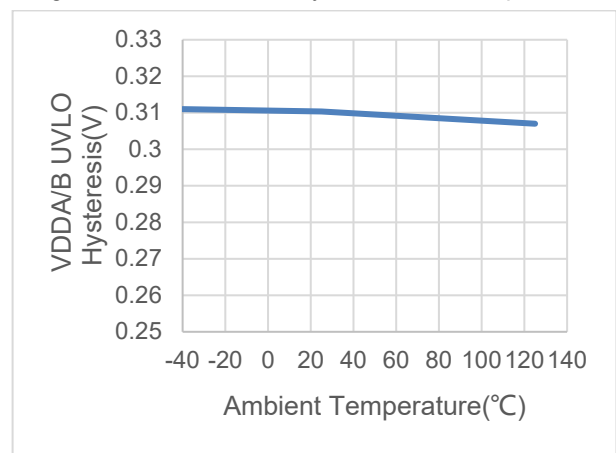


Figure 6.10 6V VDDA/B UVLO Hysteresis vs. Temperature

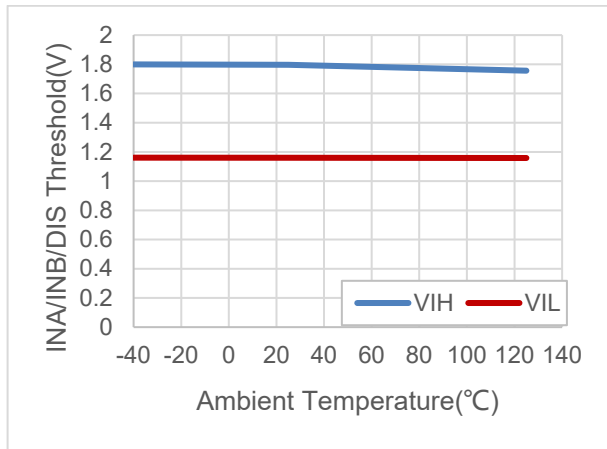


Figure 6.11 INA/INB/DIS Threshold vs. Temperature

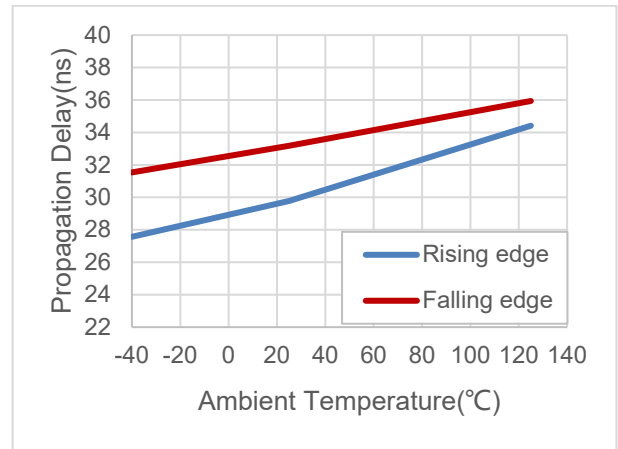


Figure 6.12 Propagation Delay vs. Temperature

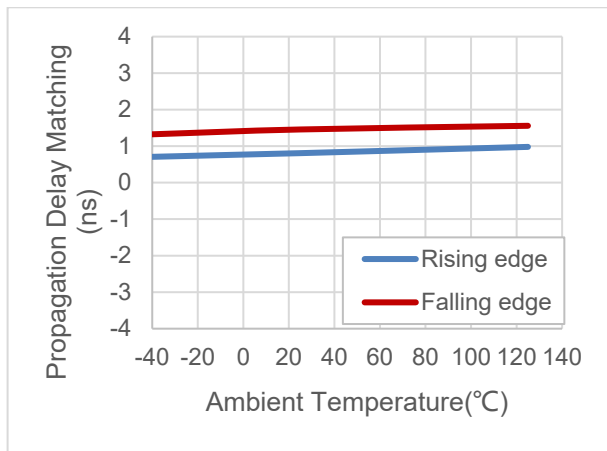


Figure 6.13 Propagation Delay Matching vs. Temperature

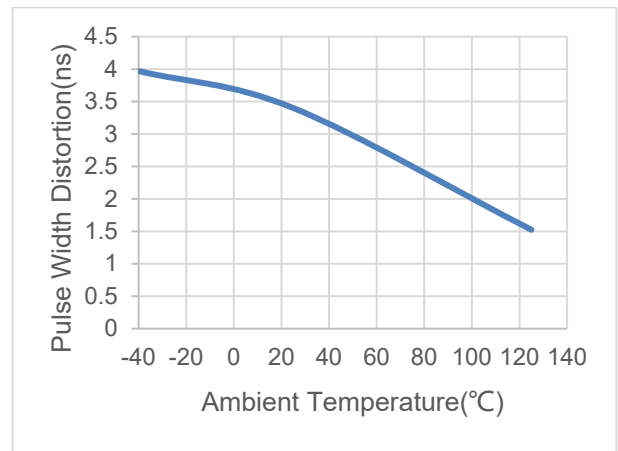


Figure 6.14 Pulse Width Distortion vs. Temperature

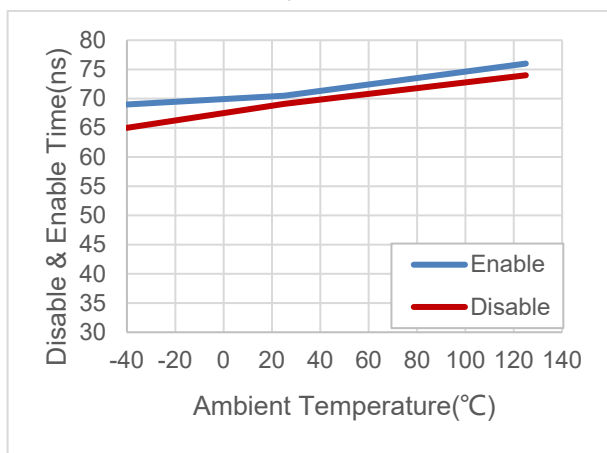


Figure 6.15 Disable & Enable Time vs. Temperature

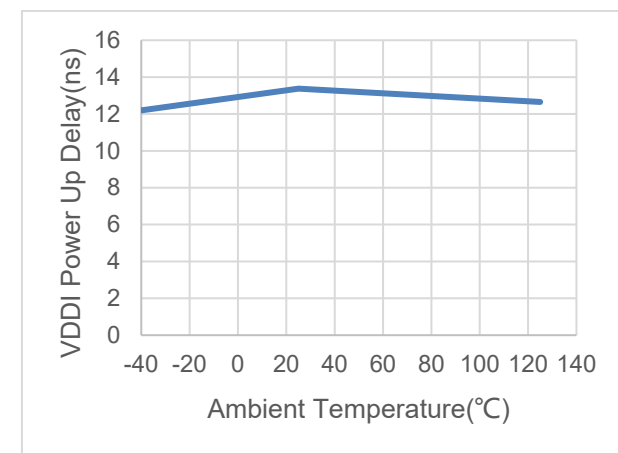


Figure 6.16 VDDI power up delay vs. Temperature

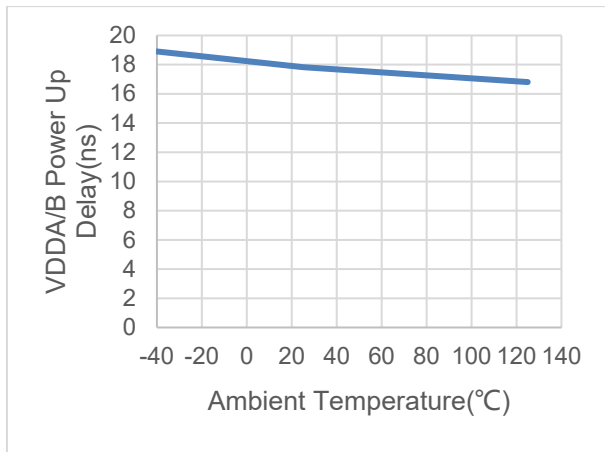


Figure 6.17 VDDA/B power up delay vs. Temperature

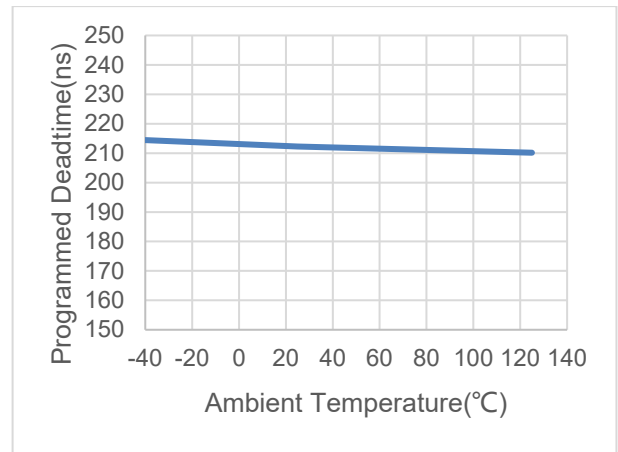


Figure 6.18 Deadtime (RDT=20kΩ) vs. Temperature

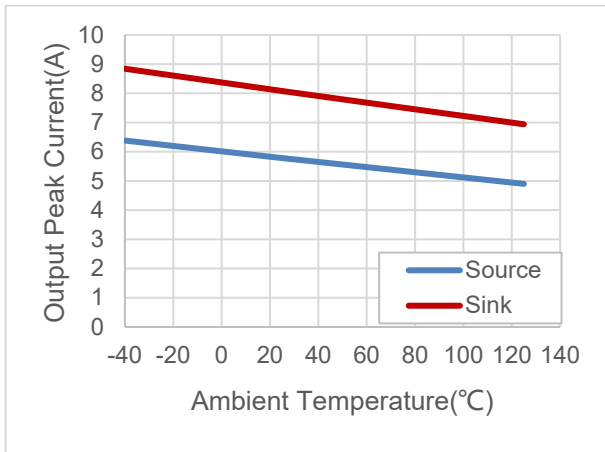


Figure 6.19 Peak current vs. Temperature

6.4. Parameter Measurement Information

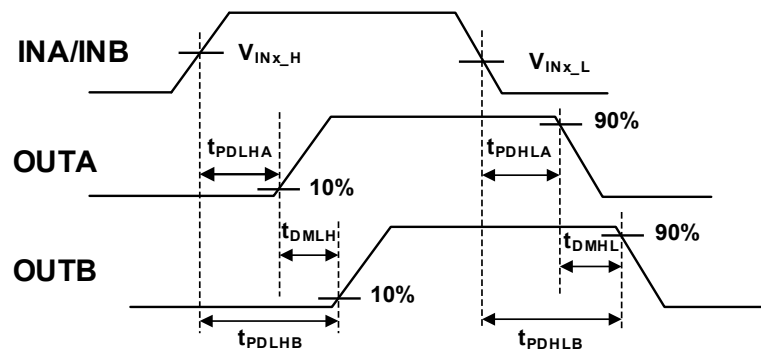


Figure 6.20 Propagation Delay and Channel to Channel Delay Match Time, connect DT to VDDI

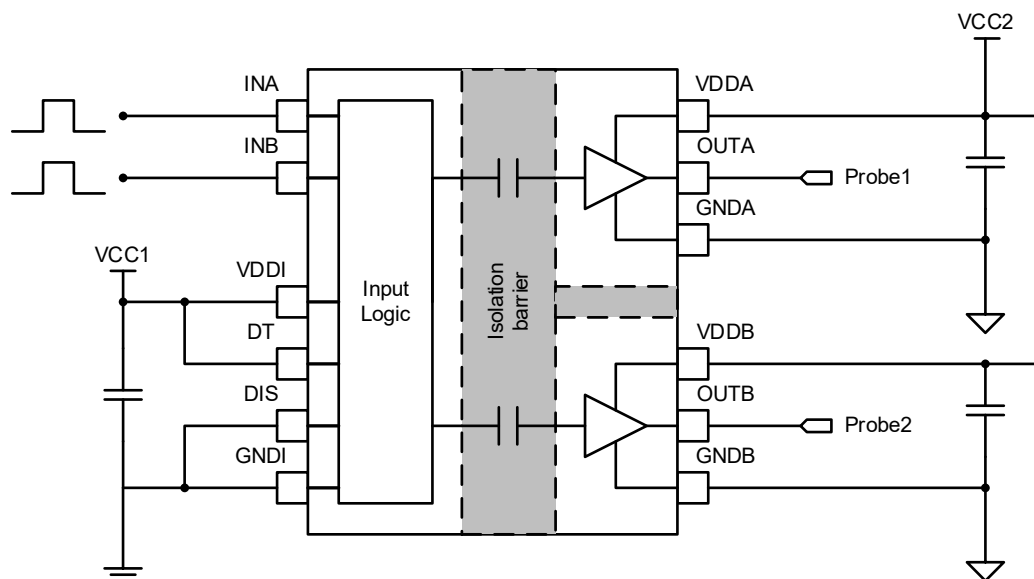


Figure 6.21 Channel to Channel Delay Match Test Circuit

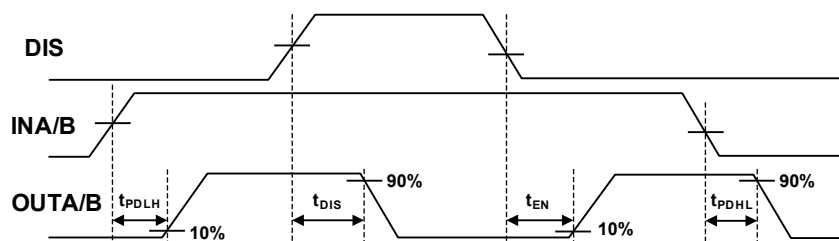


Figure 6.22 Disable Time and Enable Time

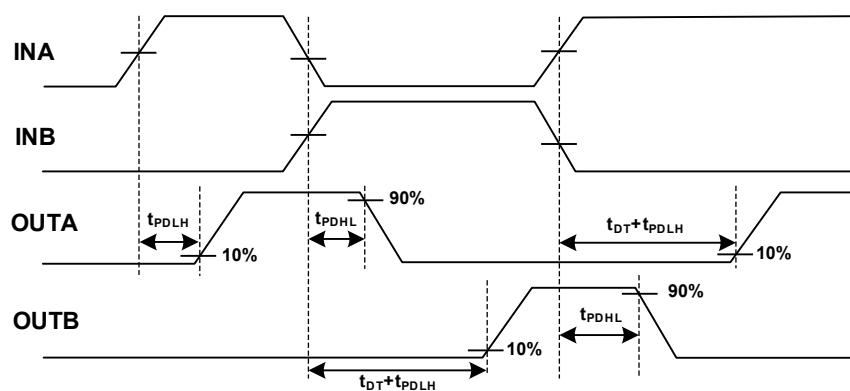


Figure 6.23 Deadtime, Determined by RDT

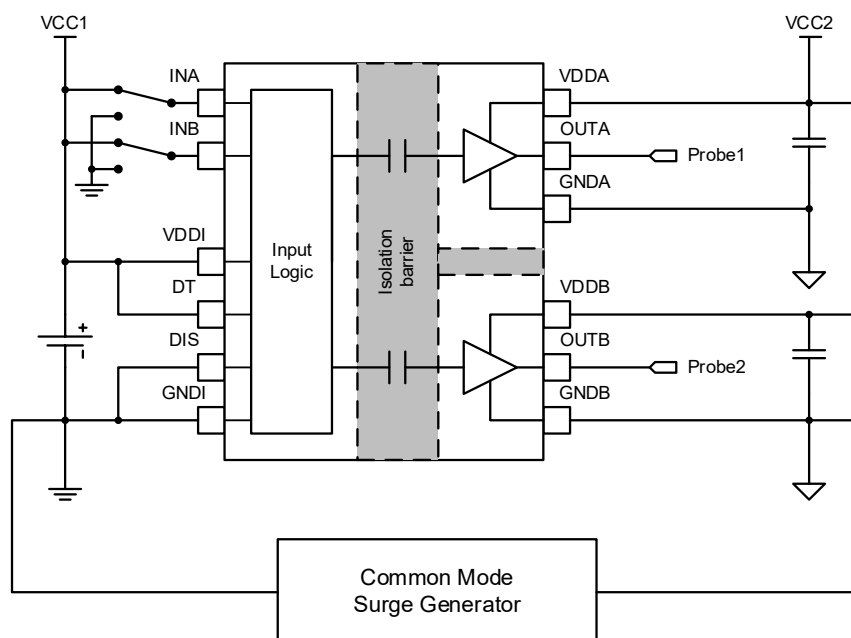


Figure 6.24 Common-Mode Transient Immunity Test Circuit

7. High Voltage Feature Description

7.1. Insulation and safety Related Specifications

Description	Test Condition	Symbol	Value			Unit
			LGA 13 (5x5)	SOW16/14	SOP16	
Min. External Air Gap (Clearance)	IEC 60664-1	CLR	3.5	8	4	mm
Min. External Tracking (Creepage)	IEC 60664-1	CPG	3.5	8	4	mm
Distance through the Insulation		DTI	28			μm
Comparative Tracking Index	DIN EN 60112 (VDE 0303-11)	CTI	>600			V
Material Group	IEC 60664-1		I			

Description	Test Condition	Value		
		LGA 13 (5x5)	SOW16/14	SOP16
Overvoltage Category per IEC60664-1	For Rated Mains Voltage ≤ 150Vrms	I to III	I to IV	I to IV
	For Rated Mains Voltage ≤ 300Vrms	I to II	I to IV	I to III
	For Rated Mains Voltage ≤ 600Vrms	I	I to IV	I to II
	For Rated Mains Voltage ≤ 1000Vrms	/	I to III	/
Climatic Category		40/125/21		
Pollution Degree	per DIN VDE 0110, Table 1	2		

7.2. Insulation Characteristics

Description			Test Condition	Symbol	Value			Unit
					LGA 13 (5x5)	SOW16/14	SOP16	
Maximum Working Isolation Voltage			AC voltage	V_{IOWM}	560	1000	700	V_{RMS}
			DC voltage		792	1414	990	V_{DC}
Maximum Repetitive Isolation Voltage				V_{IORM}	792	1414	990	V_{peak}
Apparent Charge			Method a, after Input/output safety test subgroup 2/3, $V_{ini}=V_{IOTM}$, $t_{ini} = 60s$, $V_{pd(m)}=1.2*V_{IORM}$, $t_m=10s$.	q_{pd}	/	<5	/	pC
			Method a, after environmental tests subgroup 1, $V_{ini}=V_{IOTM}$, $t_{ini}=60s$, $V_{pd(m)}=1.6*V_{IORM}$, $t_m=10s$		/		/	pC
			Method b, routine test (100% production) and preconditioning (type test); $V_{ini}=1.2*V_{IOTM}$, $t_{ini} = 1s$, $V_{pd(m)}=1.875*V_{IORM}$, $t_m=1s$ (method b1) or $V_{pd(m)}=V_{ini}$, $t_m=t_{ini}$ (method b2)		/		/	pC
Apparent Charge			Method a, after Input/output safety test subgroup 2/3, $V_{ini}=V_{IOTM}$, $t_{ini} = 60s$, $V_{pd(m)}=1.2*V_{IORM}$, $t_m=10s$	q_{pd}	<5	/	<5	pC
			Method a, after environmental tests subgroup 1, $V_{ini}=V_{IOTM}$, $t_{ini}=60s$, $V_{pd(m)}=1.3*V_{IORM}$, $t_m=10s$					pC
			Method b, routine test (100% production) and preconditioning (type test); $V_{ini}=1.2*V_{IOTM}$, $t_{ini}=1s$ $V_{pd(m)}=1.5*V_{IORM}$, $t_m=1s$ (method b1) or $V_{pd(m)}=V_{ini}$, $t_m=t_{ini}$ (method b2)					pC
Maximum Transient Isolation Voltage			$t = 60 \text{ sec}$	V_{IOTM}	3535	8000	4242	V_{peak}
Maximum impulse voltage			Tested in air, 1.2/50-us waveform per IEC62368-1	V_{imp}	/	6000	3500	V_{PEAK}

Description	Test Condition	Symbol	Value			Unit
			LGA 13 (5x5)	SOW16/14	SOP16	
Maximum Surge Isolation Voltage	Test method per IEC62368-1, 1.2/50us waveform, $V_{IOSM} \geq V_{IMP} \times 1.3$	V_{IOSM}	3500	10000	6000	V_{peak}
Isolation Resistance	$V_{IO} = 500 \text{ V}$, $T_{amb} = 25 \text{ }^{\circ}\text{C}$	R_{IO}	$>10^{12}$			Ω
	$V_{IO} = 500 \text{ V}$, $T_{amb} = T_s$		$>10^9$			Ω
	$V_{IO} = 500 \text{ V}$, $100 \text{ }^{\circ}\text{C} \leq T_{amb} \leq 125 \text{ }^{\circ}\text{C}$		$>10^{11}$			Ω
Isolation Capacitance	$f = 1\text{MHz}$	C_{IO}	1.2			pF
Insulation Specification per UL1577						
Withstand Isolation Voltage	$V_{TEST} = 1.2 \times V_{ISO}$, $t = 1 \text{ sec}$, 100% production test	V_{ISO}	2500	5700	3000	V_{rms}

7.3. Safety-Limiting Values

Basic isolation safety-limiting values as outlined in VDE-0884-11 of NSI6602Hx-xLAR (LGA13)

Description	Test Condition	Side	Value	Unit
Safety Supply Power	$R_{\theta JA} = 209.5 \text{ }^{\circ}\text{C/W}^{(1)}$, $T_J = 150 \text{ }^{\circ}\text{C}$, $T_A = 25 \text{ }^{\circ}\text{C}$	Input	90	mW
		Driver A, Driver B	254	mW
		Total	598	mW
Safety Supply Current	$R_{\theta JA} = 209.5 \text{ }^{\circ}\text{C/W}^{(1)}$, $V_{DDA/B} = 15\text{V}$, $T_J = 150 \text{ }^{\circ}\text{C}$, $T_A = 25 \text{ }^{\circ}\text{C}$	Driver A, Driver B	17	mA
	$R_{\theta JA} = 209.5 \text{ }^{\circ}\text{C/W}^{(1)}$, $V_{DDA/B} = 25\text{V}$, $T_J = 150 \text{ }^{\circ}\text{C}$, $T_A = 25 \text{ }^{\circ}\text{C}$	Driver A, Driver B	10.2	mA
Safety Temperature ²⁾			150	$^{\circ}\text{C}$

- 1) Calculate with the junction-to-air thermal resistance, $R_{\theta JA}$, of LGA13 package ([Thermal Information Table](#)) which is that of a device installed on a low effective thermal conductivity test board (1s) according to JESD51-3.
- 2) The maximum safety temperature has the same value as the maximum junction temperature (T_J) specified for the device.

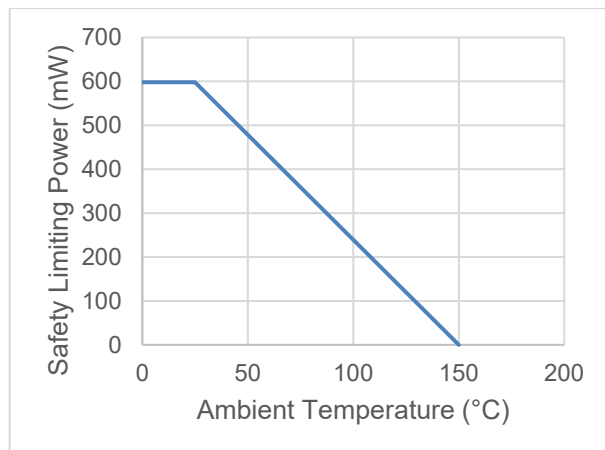


Figure 7.1 NSI6602Hx-DLAR Thermal Derating Curve, Dependence of Safety Limiting Values with Case Temperature per DIN VDE V 0884-17. Reinforced isolation safety-limiting values as outlined in VDE-0884-11 of NSI6602Hx-xSWxR (SOW16/SOW14)

Description	Test Condition	Side	Value	Unit
Safety Supply Power	$R_{\theta JA} = 97 \text{ }^{\circ}\text{C/W}^{(1)}$, $T_J = 150 \text{ }^{\circ}\text{C}$, $T_A = 25 \text{ }^{\circ}\text{C}$	Input	90	mW
		Driver A, Driver B	599	mW
		Total	1288	mW
Safety Supply Current	$R_{\theta JA} = 97 \text{ }^{\circ}\text{C/W}^{(1)}$, $V_{DDA/B} = 15\text{V}$, $T_J = 150 \text{ }^{\circ}\text{C}$, $T_A = 25 \text{ }^{\circ}\text{C}$	Driver A, Driver B	40	mA
	$R_{\theta JA} = 97 \text{ }^{\circ}\text{C/W}^{(1)}$, $V_{DDA/B} = 25\text{V}$, $T_J = 150 \text{ }^{\circ}\text{C}$, $T_A = 25 \text{ }^{\circ}\text{C}$	Driver A, Driver B	24	mA
Safety Temperature ²⁾			150	$^{\circ}\text{C}$

- 1) Calculate with the junction-to-air thermal resistance, $R_{\theta JA}$, of SOW16/SOW14 package ([Thermal Information Table](#)) which is that of a device installed on a low effective thermal conductivity test board (1s) according to JESD51-3.
- 2) The maximum safety temperature has the same value as the maximum junction temperature (T_J) specified for the device.

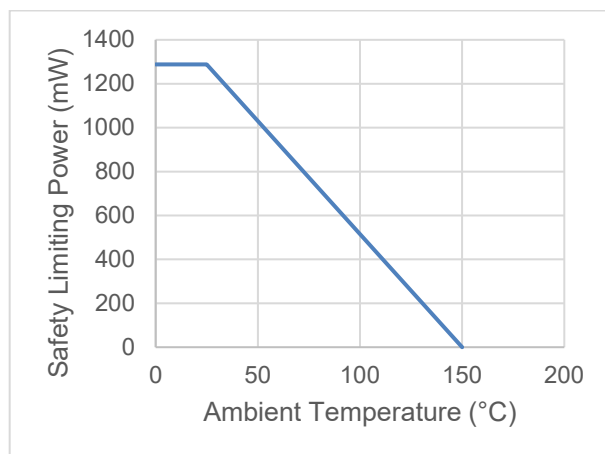


Figure 7.2 NSI6602Hx-DSWR Thermal Derating Curve, Dependence of Safety Limiting Values with Case Temperature per DIN VDE V 0884-17. Basic isolation safety-limiting values as outlined in VDE-0884-11 of NSI6602Hx-xSPxR (SOP16)

Description	Test Condition	Side	Value	Unit
Safety Supply Power	$R_{\theta JA} = 150.5 \text{ }^{\circ}\text{C/W}^{(1)}$, $T_J = 150 \text{ }^{\circ}\text{C}$, $T_A = 25 \text{ }^{\circ}\text{C}$	Input	90	mW
		Driver A, Driver B	370	mW
		Total	830	mW
Safety Supply Current	$R_{\theta JA} = 150.5 \text{ }^{\circ}\text{C/W}^{(1)}$, $V_{DDA/B} = 15\text{V}$, $T_J = 150 \text{ }^{\circ}\text{C}$, $T_A = 25 \text{ }^{\circ}\text{C}$	Driver A, Driver B	24.7	mA
	$R_{\theta JA} = 150.5 \text{ }^{\circ}\text{C/W}^{(1)}$, $V_{DDA/B} = 25\text{V}$, $T_J = 150 \text{ }^{\circ}\text{C}$, $T_A = 25 \text{ }^{\circ}\text{C}$	Driver A, Driver B	14.8	mA
Safety Temperature ²⁾			150	$^{\circ}\text{C}$

- 1) Calculate with the junction-to-air thermal resistance, $R_{\theta JA}$, of SOP16 package ([Thermal Information Table](#)) which is that of a device installed on a low effective thermal conductivity test board (1s) according to JESD51-3.
- 2) The maximum safety temperature has the same value as the maximum junction temperature (T_J) specified for the device.

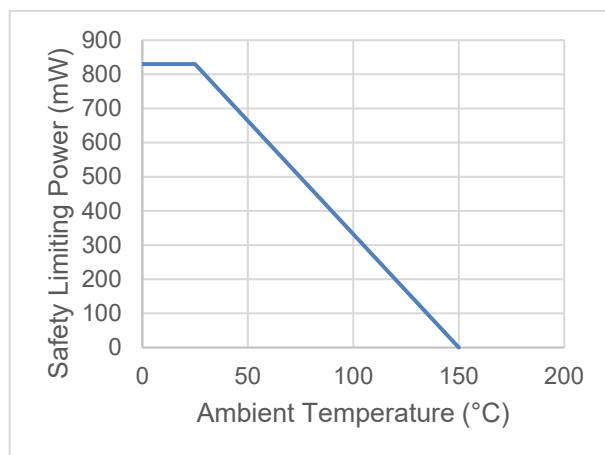


Figure 7.3 NSI6602Hx-DSPxR Thermal Derating Curve, Dependence of Safety Limiting Values with Case Temperature per DIN VDE V 0884-17.

7.4. Safety-Related Certifications

The NSI6602Hx-DLAR(LGA13 5x5mm) are approved by the organizations listed in table.

UL		TUV		CQC
UL1577 Component Recognition Program	Approved under CSA Component Acceptance Notice 5A	DIN EN IEC 60747-17 (VDE 0884-17)	Certified according to GB4943.1	
Single 2500Vrms voltage	Protection, Isolation	Single 2500Vrms voltage	Protection, Isolation	Basic insulation
E500602	E500602	R50574061	CQC21001289933	

The NSI6602Hx-DSWR are approved or pending approval by the organizations listed in table.

UL		VDE		CQC
UL 1577 Component Recognition Program	Approved under CSA Component Acceptance Notice 5A	Certified according to DIN EN IEC 60747-17 (VDE 0884-17)		Certified according to GB4943.1
Single 5700Vrms voltage	Protection, Isolation	Single 5700Vrms voltage	Protection, Isolation	Reinforced insulation
E500602	E500602	40052820	CQC20001264939	

The NSI6602Hx-DSWKR are approved or pending approval by the organizations listed in table.

UL		VDE		CQC
UL 1577 Component Recognition Program	Approved under CSA Component Acceptance Notice 5A	Certified according to DIN EN IEC 60747-17 (VDE 0884-17)		Certified according to GB4943.1
Single 5700Vrms voltage	Protection, Isolation	Single 5700Vrms voltage	Protection, Isolation	Reinforced insulation
E500602	E500602	40052820	CQC21001289932	

The NSI6602Hx-DSPNR(SOP16) are approved by the organizations listed in table.

UL		VDE		CQC
UL 1577 Component Recognition Program	Approved under CSA Component Notice 5A	Certified according to DIN VDE V 0884-17	Certified according to GB4943.1	
Single 3000Vrms voltage	Protection, Isolation	Single 3000Vrms voltage	Protection, Isolation	Basic insulation at $V_{IORM}=990V_{PEAK}$ $V_{IOSM}=6000V_{PEAK}$ $V_{IOTM}=4242V_{PEAK}$
E500602	E500602	400501210	CQC21001289931	

8. Function Description

8.1. Overview

NSI6602H is a high reliability dual channel isolated gate driver which could be used in variety switching power and motor drive topologies. NSI6602H has some useful protections, such as under voltage lock out (UVLO) for both input and output supply, a disable pin, deadtime control, default low output as input is floating. The functional circuit block diagram is shown as below:

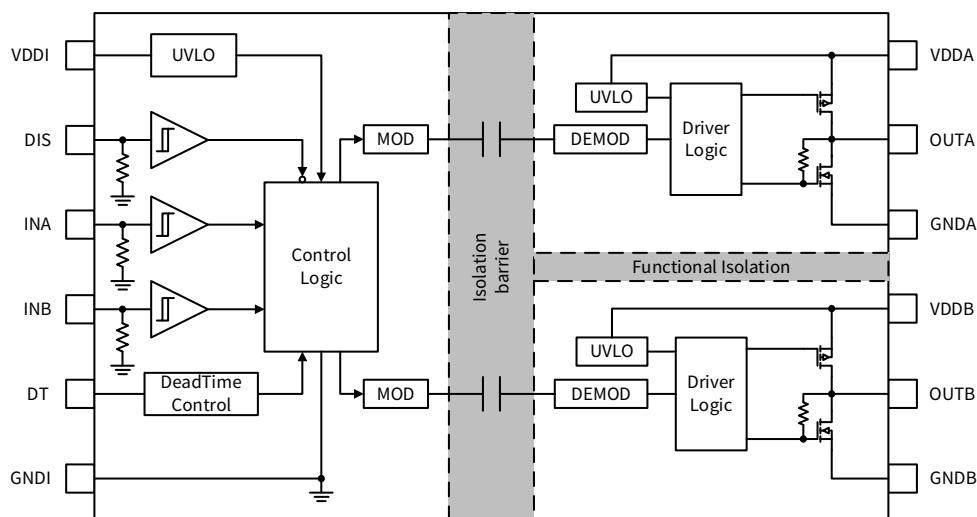


Figure 8.1 Functional Block Diagram

8.2. Undervoltage Lockout (UVLO)

The NSI6602H has an internal under voltage lock out (UVLO) protection on both input and output supply circuit blocks. The driver output is held low by an active clamp circuit when the supply voltage of VDDI or VDDA/VDD B is lower than V_{VDD_ON} at power-up status or lower than V_{VDD_OFF} after power-up, regardless of the status of the input pins.

The VDDI and VDDA/B UVLO protections have hysteresis (V_{VDD_HYS}) to prevent chatter noise from VDD supply and allow small drops in supply power which are usually happen during startup.

8.3. Input and Output Logic Table

When the device is powered up, setting the DIS pin high can shut down both outputs simultaneously. Left open or grounding the DIS pin can allow the device operating normally.

Table 8.1 Output status vs Input and Power status

VDDI status	VDDA/B status	DIS	IN		OUT		NOTE ¹⁾
			A	B	A	B	
PU	PU	L or O	L	H	L	H	If Deadtime function is used, output transits to high after the deadtime expires.
PU	PU	L or O	H	L	H	L	
PU	PU	L or O	H	H	H	H	DT pin is pulled to VDDI.
PU	PU	L or O	H	H	L	L	DT is left open or programmed with R _{DT} .
PU	PU	L or O	L	L	L	L	
PU	PU	L or O	O	O	L	L	
PU	PU	H	X	X	L	L	
PU	PD	X	X	X	L	L	
PD	PU	X	X	X	L	L	

1) PD= Power Down; PU= Power Up; H= Logic High; L= Logic Low; O= Left Open; X= Irrelevant.

8.4. Programmable Deadtime (DT pin)

8.4.1. Pulling the DT Pin to VDDI

This allows outputs to match inputs completely and no deadtime is asserted.

8.4.2. DT Pin Left Open or Connected to a Programming Resistor between DT and GNDI Pins

If the DT pin is left open, the deadtime duration (t_{DT}) is set to <35ns. t_{DT} can be programmed by placing a resistor, R_{DT}, between the DT pin and GNDI. The appropriate R_{DT} value can be determined from Equation 1, where R_{DT} is in kΩ and t_{DT} in ns:

$$t_{DT} \approx 10 \times R_{DT} \quad (1)$$

The recommended value of R_{DT} is between from 1kΩ to 200kΩ. The steady state voltage at DT pin is about 0.8V and the DT pin current will be less than 10uA when R_{DT} =100kΩ. It is also recommended to parallel a ceramic capacitor, for example 2.2nF, with R_{DT} to achieve better noise immunity.

The programmed deadtime is activated by the input signal's falling edge to prevent shoot-through when the device is designed in an application of high side and low side driver. The details of input and output logic with deadtime are shown as Figure 8.2:

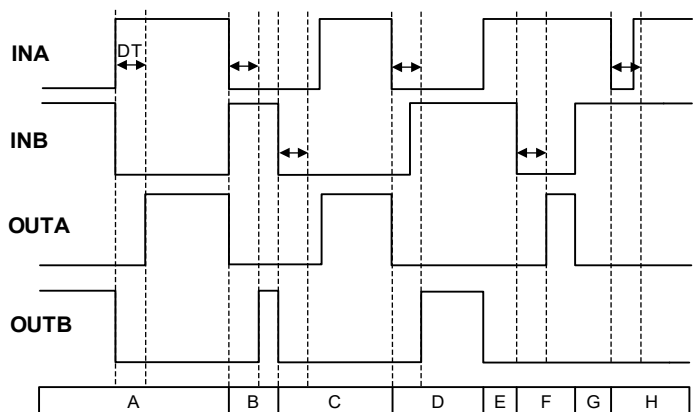


Figure 8.2 Input and Output Logic with the Programmed Deadtime

Condition	Result
A: INA goes high, and INB goes low.	OUTB goes low immediately, then OUTA goes high after the programmed deadtime which is assigned at INB goes low.
B: INA goes low, and INB goes high.	OUTA goes low immediately, then OUTB goes high after the programmed deadtime which is assigned at INA goes low.
C: INB goes low, then INA goes high after deadtime.	OUTB goes low immediately, then OUTA goes high immediately when INA goes high.
D: INA goes low, then INB goes high before deadtime.	OUTA goes low immediately, then OUTB goes high after deadtime
E: INA goes high, INB is still high.	OUTB goes low immediately and OUTA keeps low.
F: INA is still high, INB goes low.	OUTA goes high after deadtime while INB is low and OUTB keeps low.
G: INA is still high, INB goes high after deadtime	OUTA goes low immediately and OUTB keeps low.
H: INA goes low then goes high before deadtime while INB is still high.	OUTA keeps low and OUTB keeps low because deadtime control.

8.5. ESD Protection

Figure 8.3 shows the multiple diodes involved in the ESD protection part of NSI6602H.

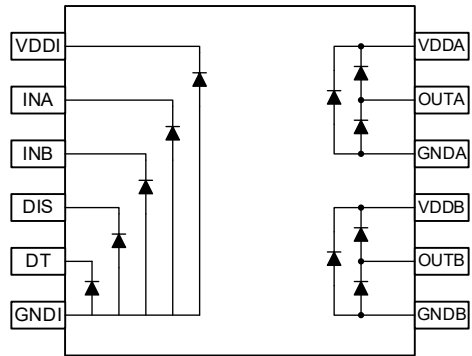


Figure 8.3 ESD Structure

9. Application Note

9.1. Typical Application Circuit

The circuit shows a typical half-bridge configuration by using the driver NSI6602H which could be used in several popular power converter topologies such as half-bridge, full bridge, LLC isolated topologies, buck-boost topologies and 3-phase motor drive applications.

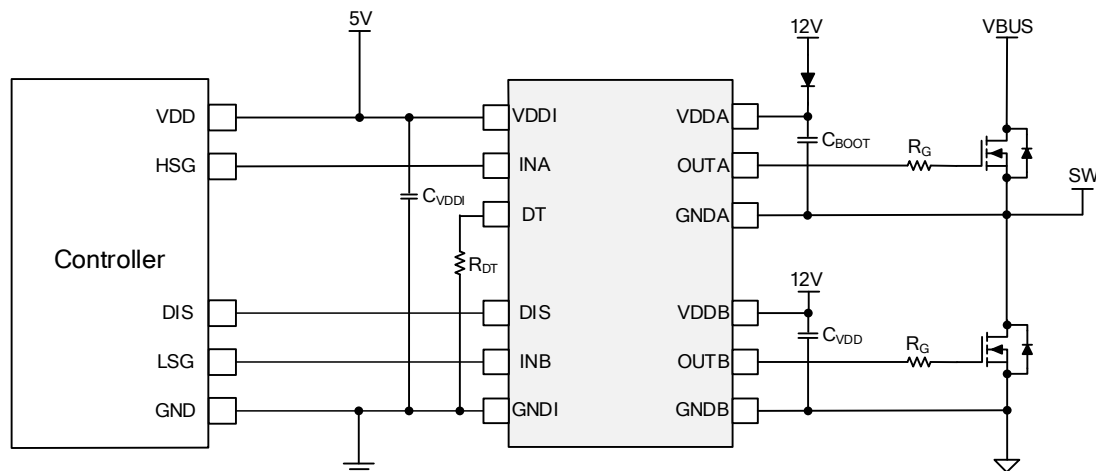


Figure 9.1 Typical Half-Bridge Application Schematic

9.2. PCB Layout

PCB layout is important to get optimal performance. Some key guidelines are given as below:

- Low-ESR and low-ESL bypass capacitors should be placed close to the device between pin VDDI to GNDI and pin VDDA/B to GNDA/B.
- There is high frequency switching current that charges and discharges the gate of external power transistor, leading to EMI and ring issues. The parasitic inductance of this loop should be minimized, by decreasing loop area and placing NSI6602H close to power transistor.
- Large amount of copper should be placed at VDDA/B pin and GNDA/B pin for thermal dissipation.
- To ensure isolation performance between primary and secondary side, the space under the device should keep free from any plane, trace, pad or via.

10.Package Information

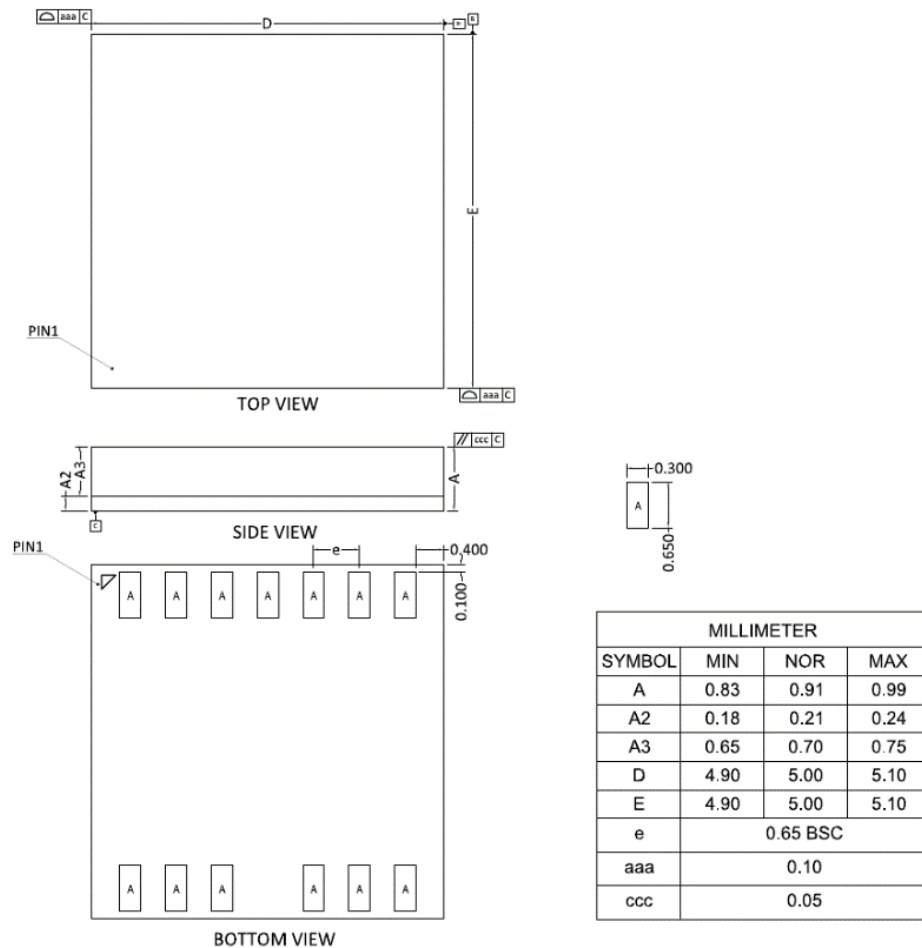


Figure 10.1 LGA13 5-mm x 5-mm Package Shape and Dimension

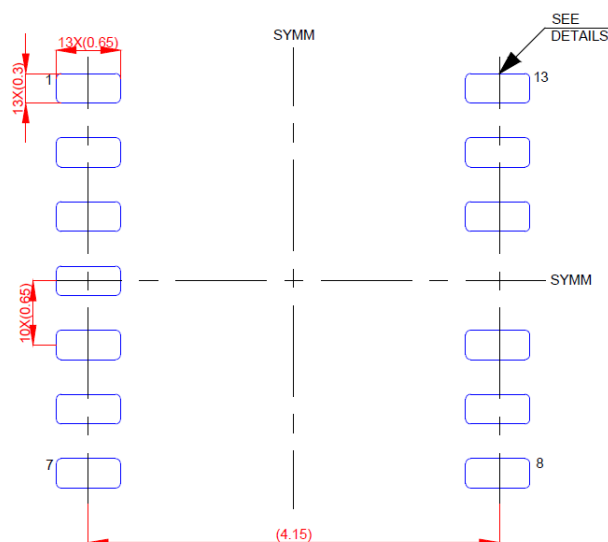


Figure 10.2 LGA13 5-mm x 5-mm Package Board Layout Example(mm)

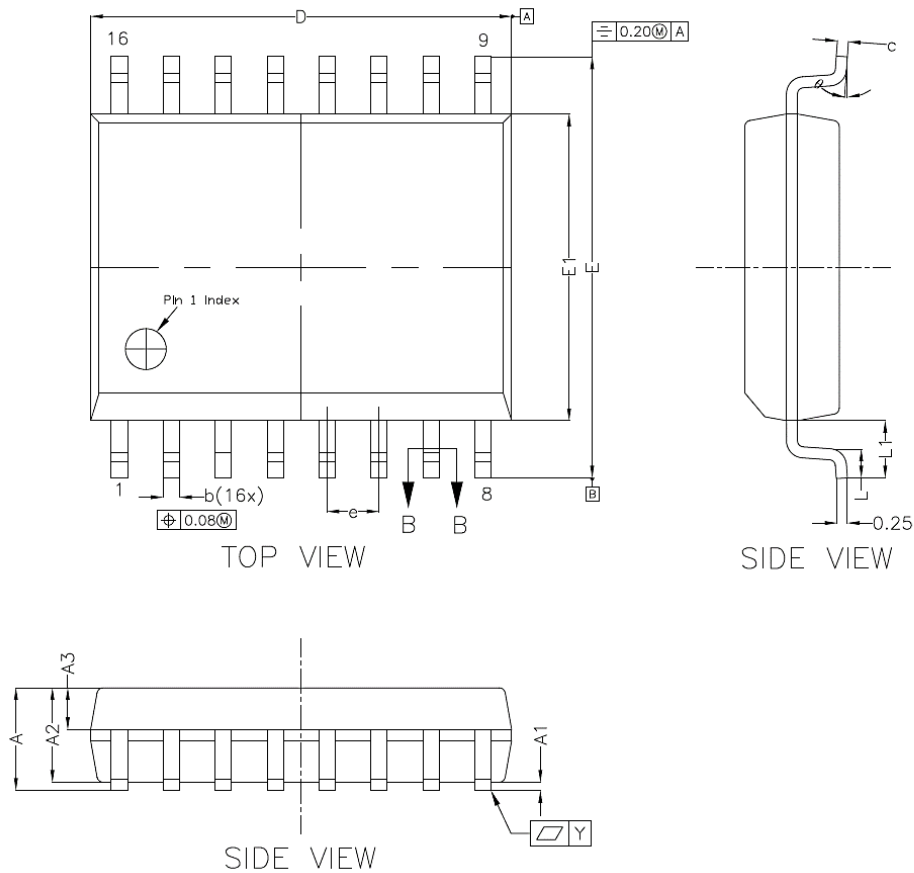


Figure 10.3 SOW16 Package Shape and Dimension

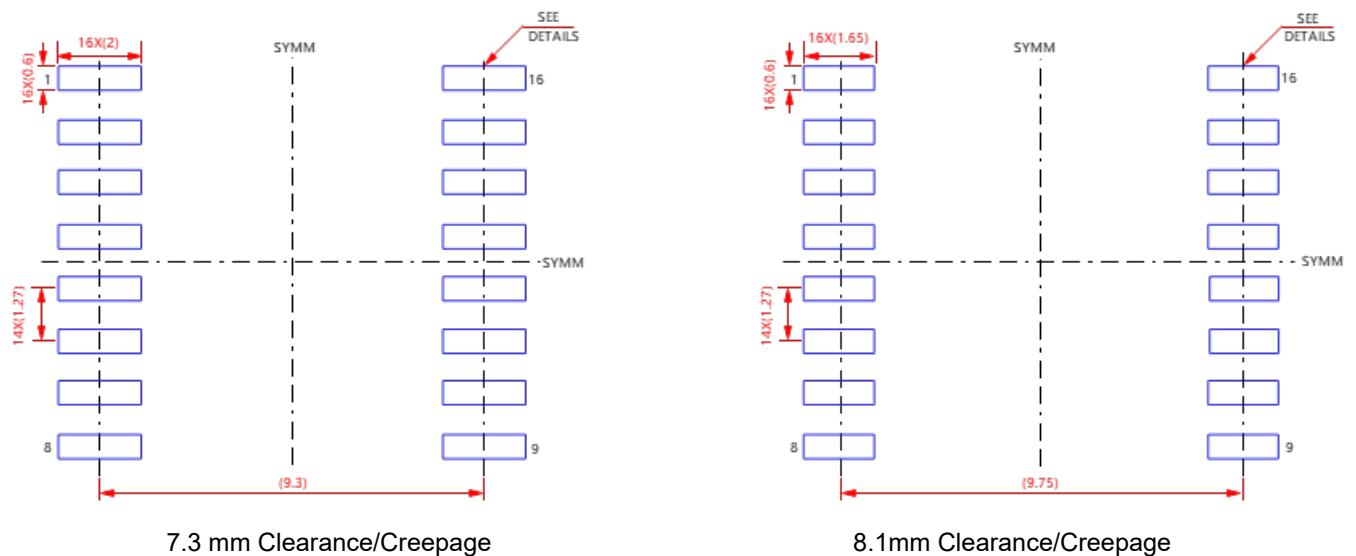


Figure 10.4 SOW16 Package Board Layout Example(mm)

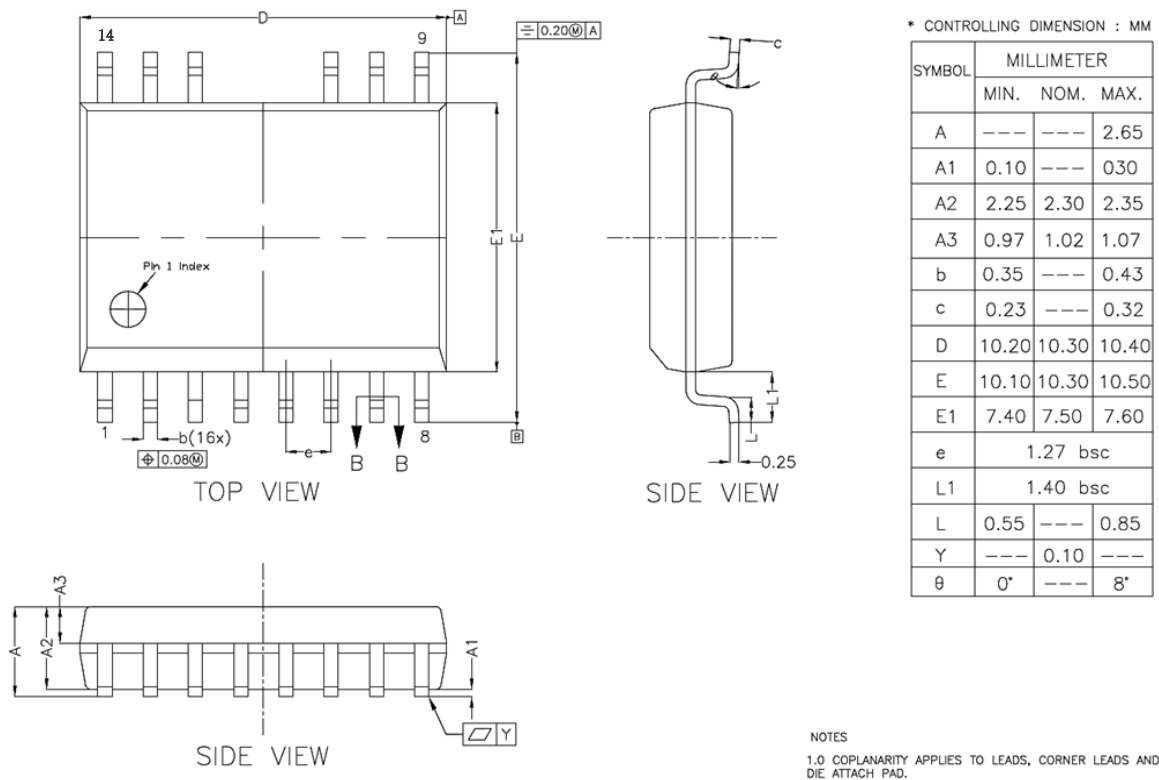


Figure 10.5 SOW14 Package Shape and Dimension

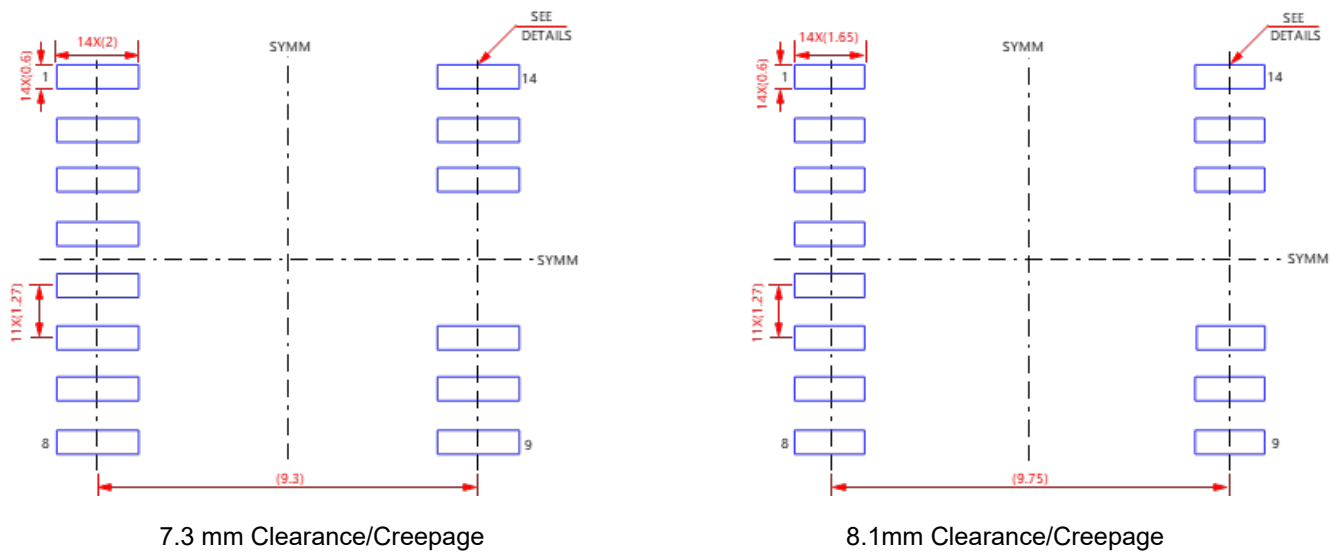


Figure 10.6 SOW14 Package Board Layout Example(mm)

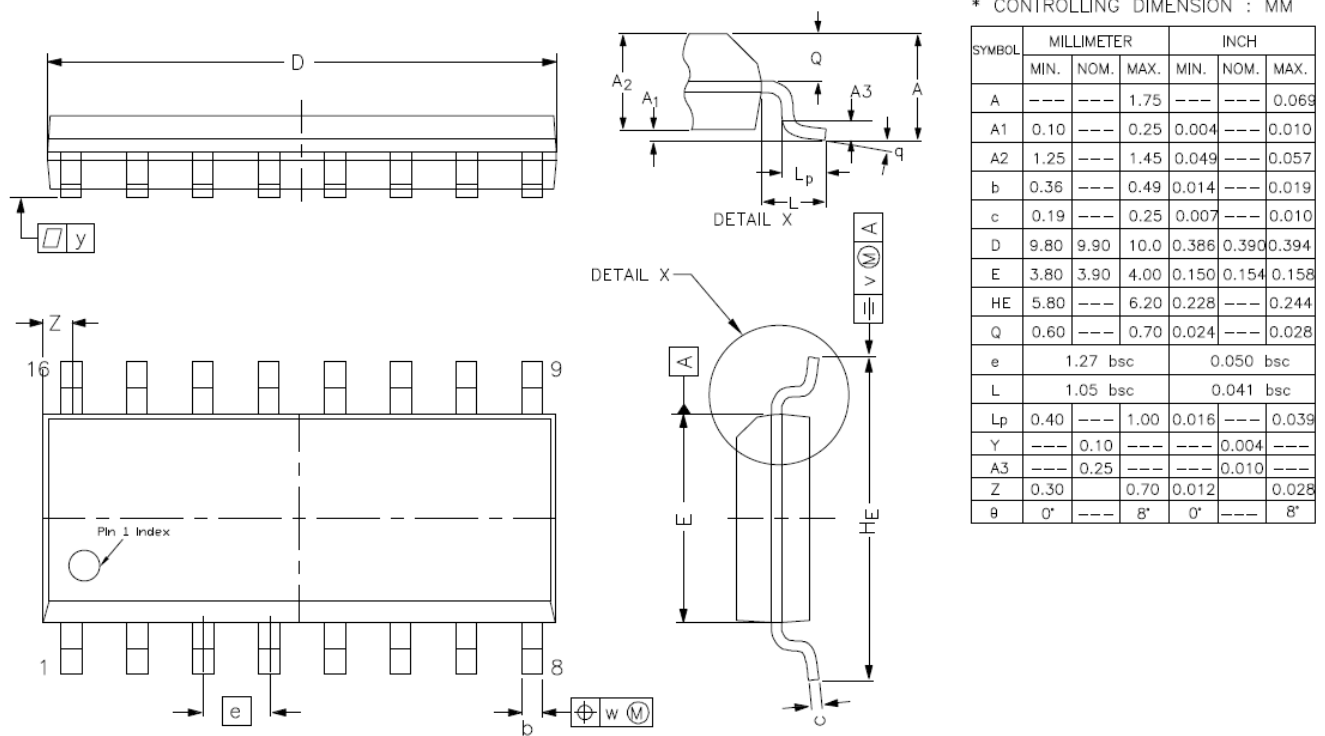


Figure 10.7 SOP16 Package Shape and Dimension

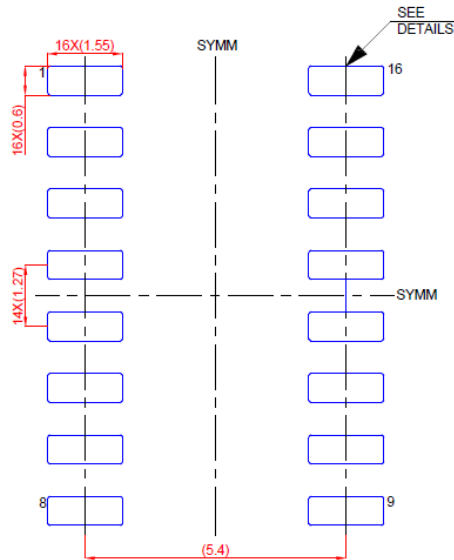


Figure 10.8 SOP16 Package Board Layout Example(mm)

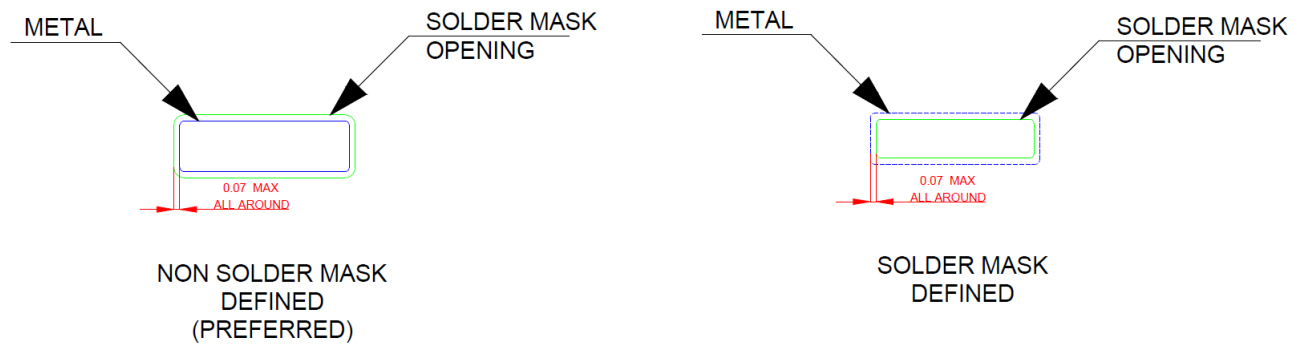


Figure 10.9 Solder Mask Details(mm)

11. Ordering Information

Part No.	Isolation Rating(kV_{RMS})	Driver- side UVLO TYP.	Temperature	Auto- motive	Body Size (mm)	Package	MSL	SPQ
NSI6602HA- DSWR	5.7	6V	-40 to 125°C	NO	10.3X7.5X2.6 5	SOW16	2	1000
NSI6602HA- DSWKR	5.7	6V	-40 to 125°C	NO	10.3X7.5X2.6 5	SOW14	2	1000
NSI6602HA- DSPNR	3.0	6V	-40 to 125°C	NO	9.9X3.9X1.75	SOP16	2	2500
NSI6602HB- DSWR	5.7	8V	-40 to 125°C	NO	10.3X7.5X2.6 5	SOW16	2	1000
NSI6602HB- DSWKR	5.7	8V	-40 to 125°C	NO	10.3X7.5X2.6 5	SOW14	2	1000
NSI6602HB- DSPNR	3.0	8V	-40 to 125°C	NO	9.9X3.9X1.75	SOP16	2	2500
NSI6602HC- DSWR	5.7	13V	-40 to 125°C	NO	10.3X7.5X2.6 5	SOW16	2	1000
NSI6602HC- DSWKR	5.7	13V	-40 to 125°C	NO	10.3X7.5X2.6 5	SOW14	2	1000
NSI6602HC- DSPNR	3.0	13V	-40 to 125°C	NO	9.9X3.9X1.75	SOP16	2	2500
NSI6602HC- DLAR	2.5	13V	-40 to 125°C	NO	5X5X0.91	LGA13 (5 X 5mm)	3	3000
NSI6602HD- DSWR	5.7	4V	-40 to 125°C	NO	10.3X7.5X2.6 5	SOW16	2	1000
NSI6602HD- DSWKR	5.7	4V	-40 to 125°C	NO	10.3X7.5X2.6 5	SOW14	2	1000
NSI6602HD- DSPNR	3.0	4V	-40 to 125°C	NO	9.9X3.9X1.75	SOP16	2	2500

12. Tape and Reel Information

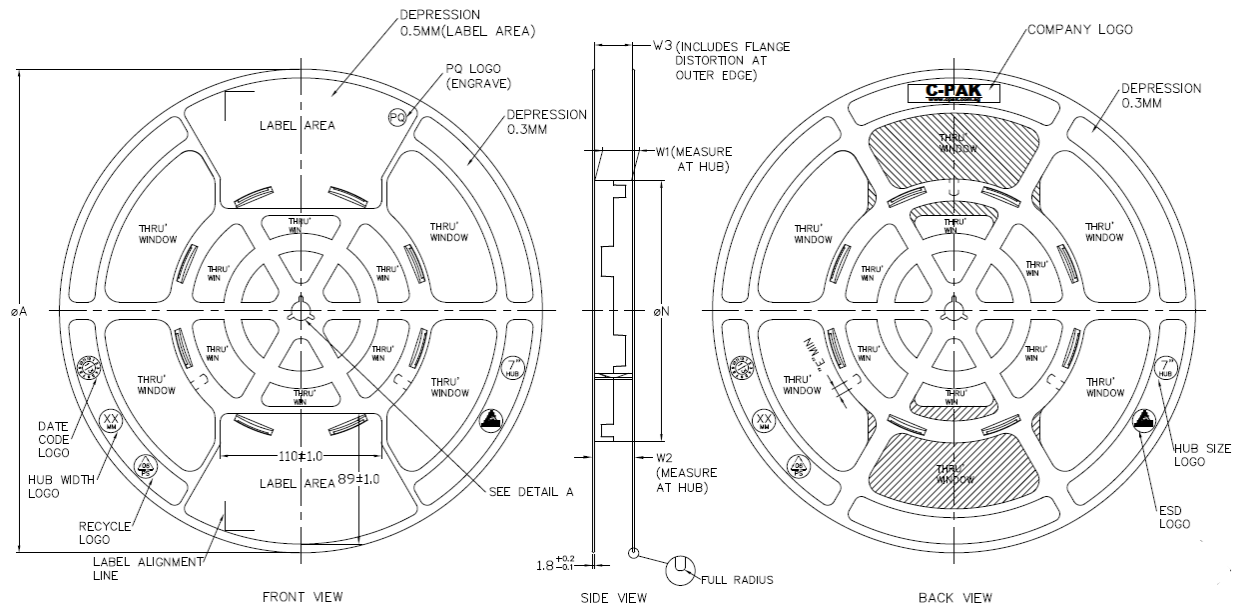


Figure 12.1 Tape Information

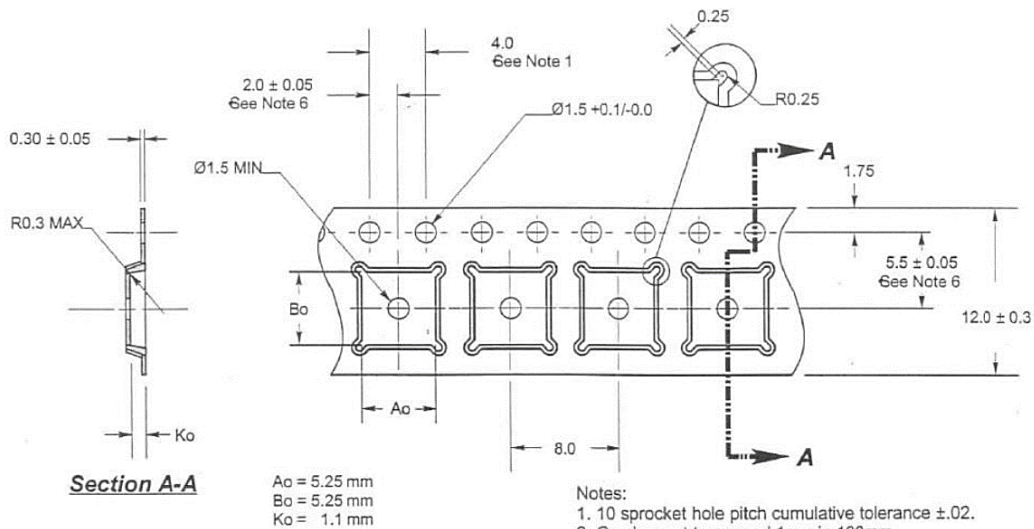
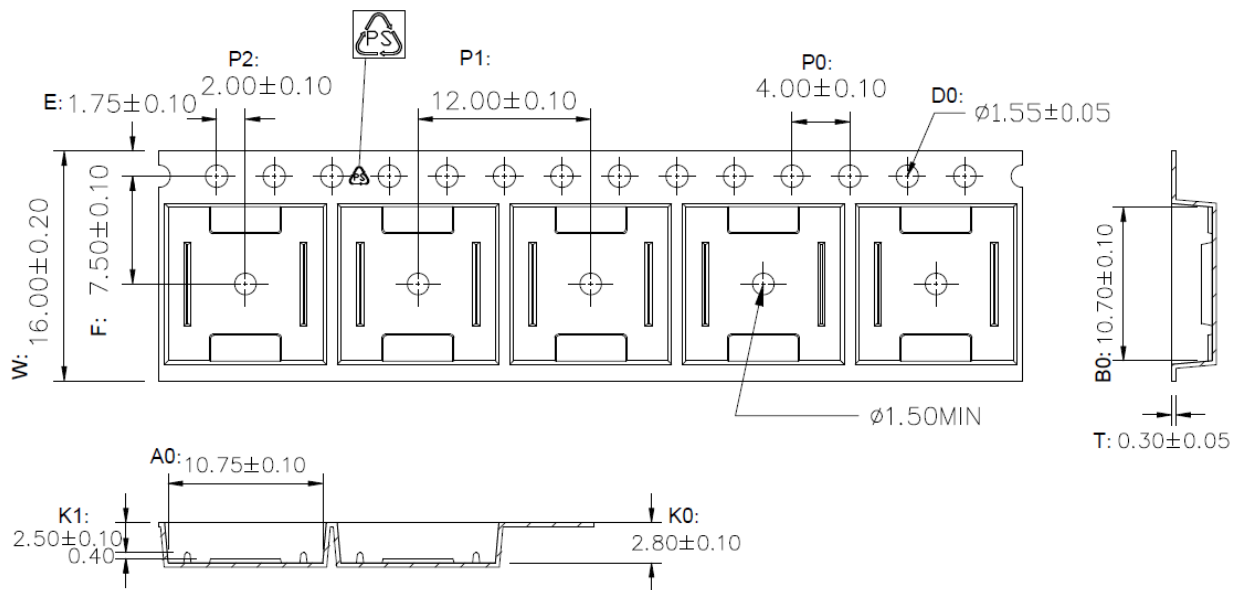


Figure 12.2 LGA13 Reel Information



1. 10 sprocket hole pitch cumulative tolerance ± 0.20 .
2. Carrier camber is within 1 mm in 250 mm.
3. Material : Black Conductive Polystyrene Alloy .
4. All dimensions meet EIA-481 requirements.
5. Thickness : $0.30 \pm 0.05 \text{ mm}$.
6. Packing length per 22" reel : 378 Meters. (N=122)
7. Component load per 13" reel : 1000 pcs.

Figure 12.3 SOW16/SOW14 Reel Information

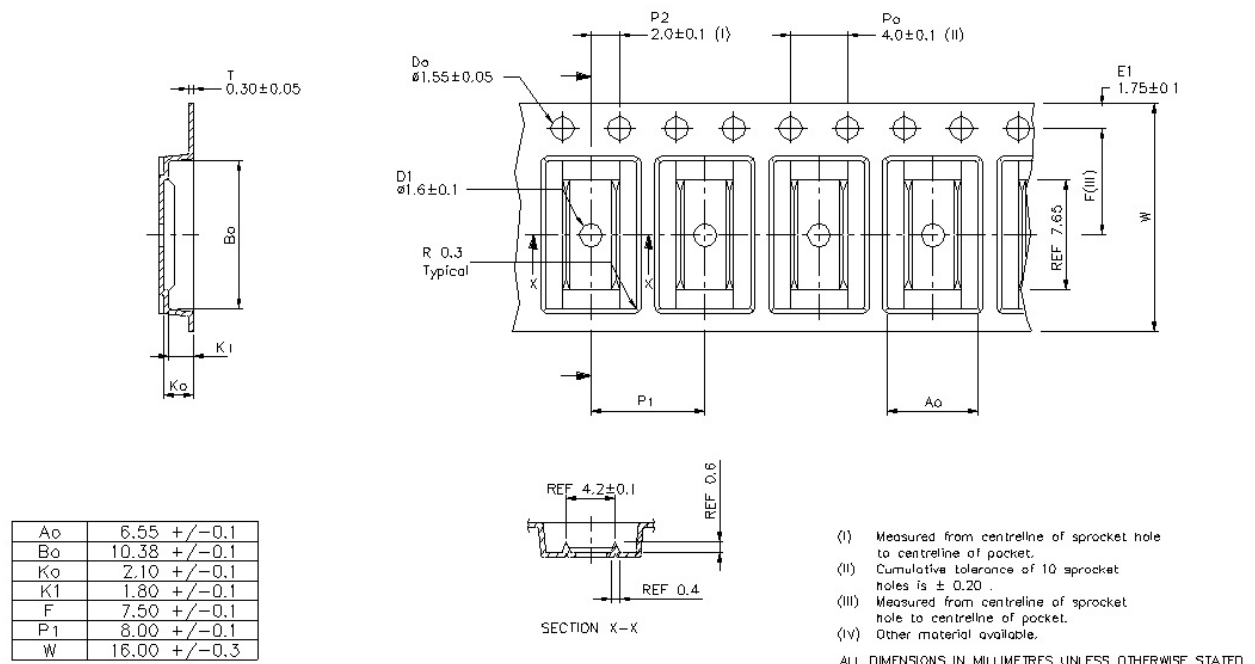


Figure 12.4 SOP16 Reel Information

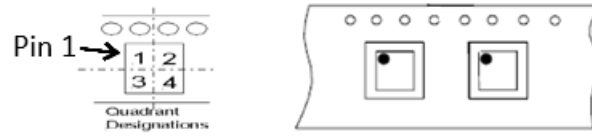


Figure 12.5 Quadrant Designation for Pin1 Orientation in Tape

13.Revision History

Revision	Description	Date
1.0	Initial version	2026/3/4

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